

XP152A01D8MR



Power MOS FET

- ◆P-Channel Power MOS FET
- ◆DMOS Structure
- ◆Low On-State Resistance: 0.48Ω (max)
- ◆Ultra High-Speed Switching
- ◆SOT-23 Package

Applications

- Notebook PCs
- Cellular and portable phones
- On-board power supplies
- Li-ion battery systems

General Description

The XP152A01D8MR is a P-Channel Power MOS FET with low on-state resistance and ultra high-speed switching characteristics.

Because high-speed switching is possible, the IC can be efficiently set thereby saving energy.

The small SOT-23 package makes high density mounting possible.

Features

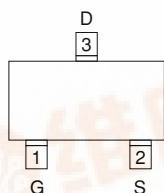
Low on-state resistance : Rds(on)=0.48Ω(Vgs=-4.5V)
: Rds(on)=0.80Ω(Vgs=-2.5V)

Ultra high-speed switching

Operational Voltage : -2.5V

High density mounting : SOT-23

Pin Configuration

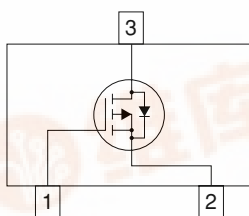


SOT-23
(TOP VIEW)

Pin Assignment

PIN NUMBER	PIN NAME	FUNCTION
1	G	Gate
2	S	Source
3	D	Drain

Equivalent Circuit



P-Channel MOS FET
(1 device built-in)

Absolute Maximum Ratings

Ta=25°C

PARAMETER	SYMBOL	RATINGS	UNITS
Drain-Source Voltage	Vdss	-20	V
Gate-Source Voltage	Vgss	±12	V
Drain Current (DC)	Id	-0.5	A
Drain Current (Pulse)	Idp	-1.5	A
Reverse Drain Current	Idr	-0.5	A
Continuous Channel Power Dissipation (note)	Pd	0.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55~150	°C

Note: When implemented on a ceramic PCB

Electrical Characteristics

DC Characteristics

 $T_a=25^{\circ}\text{C}$

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Drain Cut-off Current	I_{dss}	$V_{ds}=-20\text{V}, V_{gs}=0\text{V}$			-10	μA
Gate-Source Leakage Current	I_{gss}	$V_{gs}=\pm 12\text{V}, V_{ds}=0\text{V}$			± 10	μA
Gate-Source Cut-off Voltage	$V_{gs(off)}$	$I_d=-1\text{mA}, V_{ds}=-10\text{V}$	-0.5			V
Drain-Source On-state Resistance (note)	$R_{ds(on)}$	$I_d=-0.3\text{A}, V_{gs}=-4.5\text{V}$		0.36	0.48	Ω
		$I_d=-0.3\text{A}, V_{gs}=-2.5\text{V}$		0.6	0.8	Ω
Forward Transfer Admittance (note)	$ Y_{fs} $	$I_d=-0.3\text{A}, V_{ds}=-10\text{V}$		1		S
Body Drain Diode Forward Voltage	V_f	$I_f=-0.5\text{A}, V_{gs}=0\text{V}$		-0.8	-1.1	V

Note: Effective during pulse test.

Dynamic Characteristics

 $T_a=25^{\circ}\text{C}$

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Input Capacitance	C_{iss}	$V_{ds}=-10\text{V}, V_{gs}=0\text{V}$ $f=1\text{MHz}$		180		pF
Output Capacitance	C_{oss}			100		pF
Feedback Capacitance	C_{rss}			35		pF

Switching Characteristics

 $T_a=25^{\circ}\text{C}$

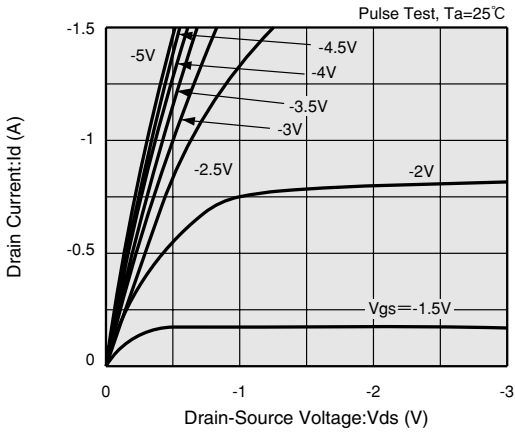
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	
Turn-on Delay Time	$t_d(on)$	$V_{gs}=-5\text{V}, I_d=-0.3\text{A}$ $V_{dd}=-10\text{V}$		10		ns	
Rise Time	t_r			15		ns	
Turn-off Delay Time	$t_d(off)$				30		ns
Fall Time	t_f				70		ns

Thermal Characteristics

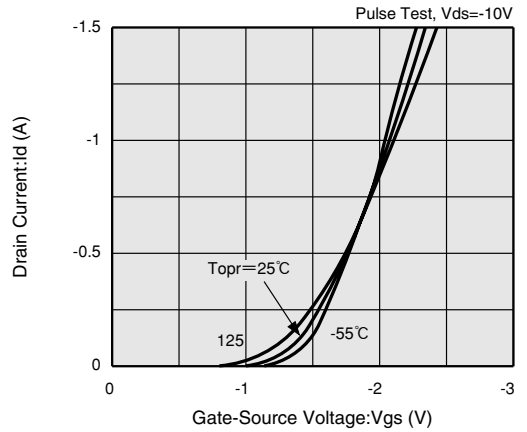
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Thermal Resistance (channel-ambience)	$R_{th}(ch-a)$	Implement on a ceramic PCB		250		$^{\circ}\text{C/W}$

Typical Performance Characteristics

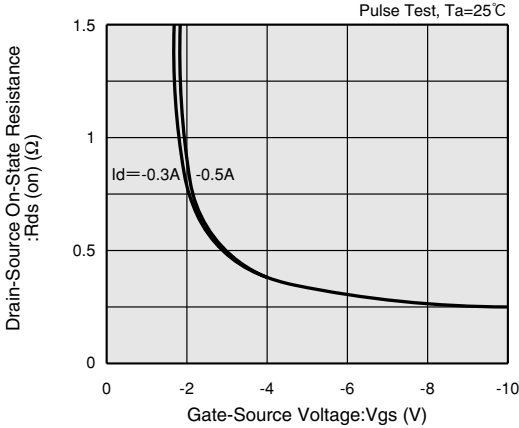
DRAIN CURRENT vs. DRAIN-SOURCE VOLTAGE



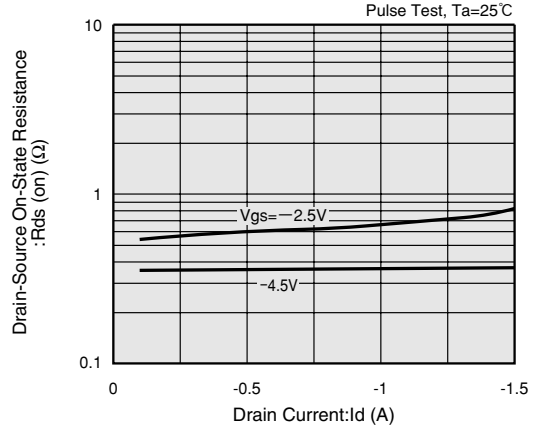
DRAIN CURRENT vs. GATE-SOURCE VOLTAGE



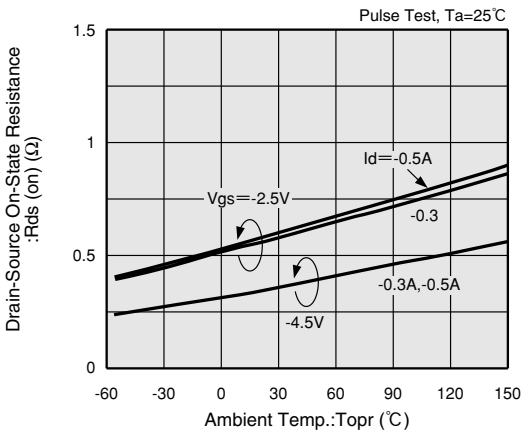
DRAIN-SOURCE ON-STATE RESISTANCE vs. GATE-SOURCE VOLTAGE



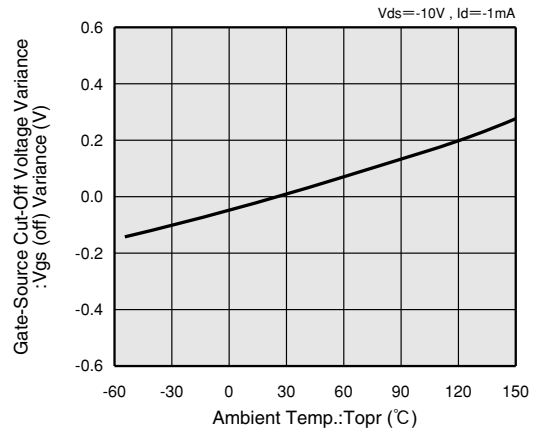
DRAIN-SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



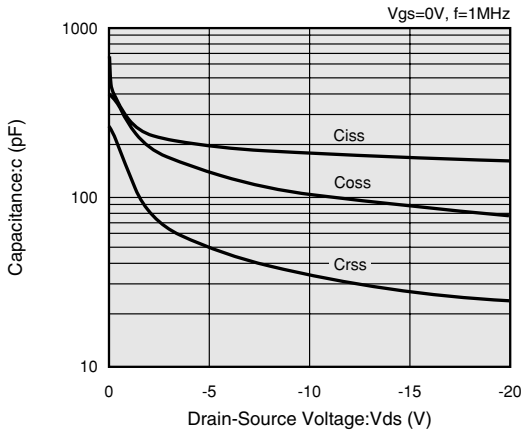
DRAIN-SOURCE ON-STATE RESISTANCE vs. AMBIENT TEMPERATURE



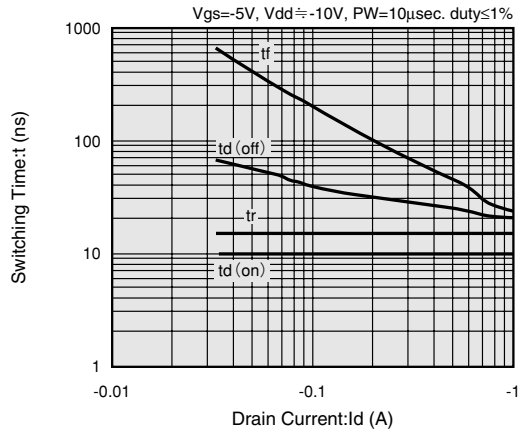
GATE-SOURCE CUT-OFF VOLTAGE VARIANCE vs. AMBIENT TEMPERATURE



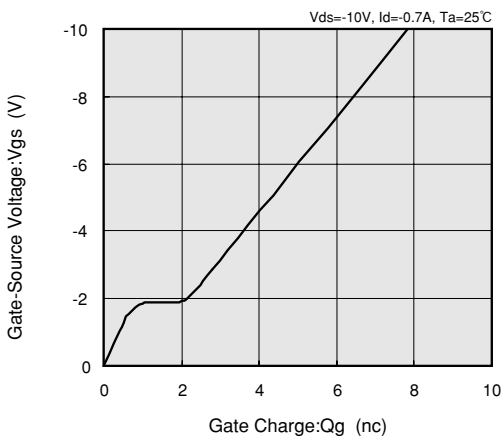
CAPACITANCE vs. DRAIN-SOURCE VOLTAGE



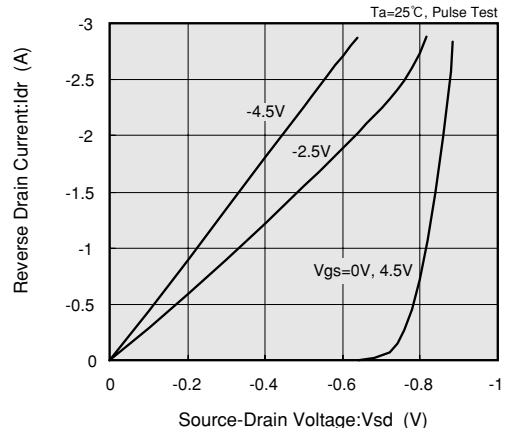
SWITCHING TIME vs. DRAIN CURRENT



GATE-SOURCE VOLTAGE vs. GATE CHARGE



REVERSE DRAIN CURRENT vs. SOURCE-DRAIN VOLTAGE



STANDARDIZED TRANSITION THERMAL RESISTANCE vs. PULSE WIDTH

